


<b>Search Notes</b>  	<b>Application/Control No.</b>  10529968	<b>Applicant(s)/Patent Under Reexamination</b>  WEIS ET AL.
	<b>Examiner</b>  STEVEN CERNOCH	<b>Art Unit</b>  3752

SEARCHED			
Class	Subclass	Date	Examiner
239	428.5	2/12/2008	SMC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	2/12/2008	SMC
EAST	10/16/2008	SMC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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